M48Z35
M48Z35Y

256 Kbit (32Kb x8) ZEROPOWER® SRAM

- INTEGRATED ULTRA LOW POWER SRAM, POWER-FAIL CONTROL CIRCUIT and BATTERY
- READ CYCLE TIME EQUALS WRITE CYCLE TIME
- AUTOMATIC POWER-FAIL CHIP DESELECT and WRITE PROTECTION
- WRITE PROTECT VOLTAGES (V_{PFD} = Power-fail Deselect Voltage):
  – M48Z35: $4.50V \leq V_{PFD} \leq 4.75V$
  – M48Z35Y: $4.20V \leq V_{PFD} \leq 4.50V$
- SELF-CONTAINED BATTERY in the CAPHAT DIP PACKAGE
- PACKAGING INCLUDES a 28-LEAD SOIC and SNAPHAT® TOP (to be Ordered Separately)
- SOIC PACKAGE PROVIDES DIRECT CONNECTION for a SNAPHAT TOP which CONTAINS the BATTERY and CRYSTAL
- PIN and FUNCTION COMPATIBLE with JEDEC STANDARD 32K x8 SRAMs

DESCRIPTION

The M48Z35/35Y ZEROPOWER® RAM is a 32 Kbit x8 non-volatile static RAM that integrates power-fail deselect circuitry and battery control logic on a single die. The monolithic chip is available in two special packages to provide a highly integrated battery backed-up memory solution.

Table 1. Signal Names

A0-A14	Address Inputs
DQ0-DQ7	Data Inputs / Outputs
$\overline{E}$	Chip Enable
$\overline{G}$	Output Enable
$\overline{W}$	Write Enable
V_{CC}	Supply Voltage
V_{SS}	Ground

SNAPHAT (SH) Battery

SOH28 (MH)

PCDIP28 (PC) Battery CAPHAT

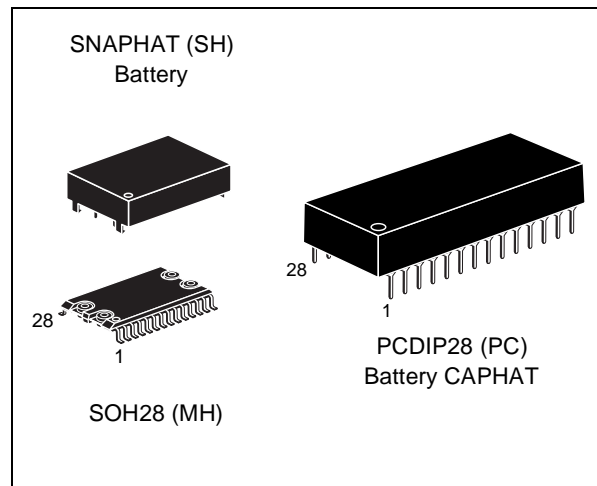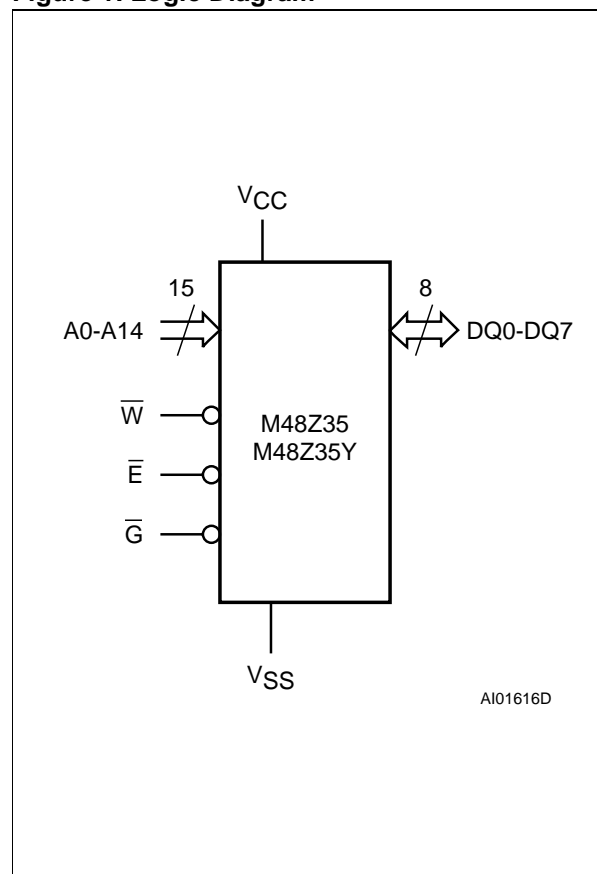### Figure 1. Logic Diagram

Figure 2A. DIP Pin Connections
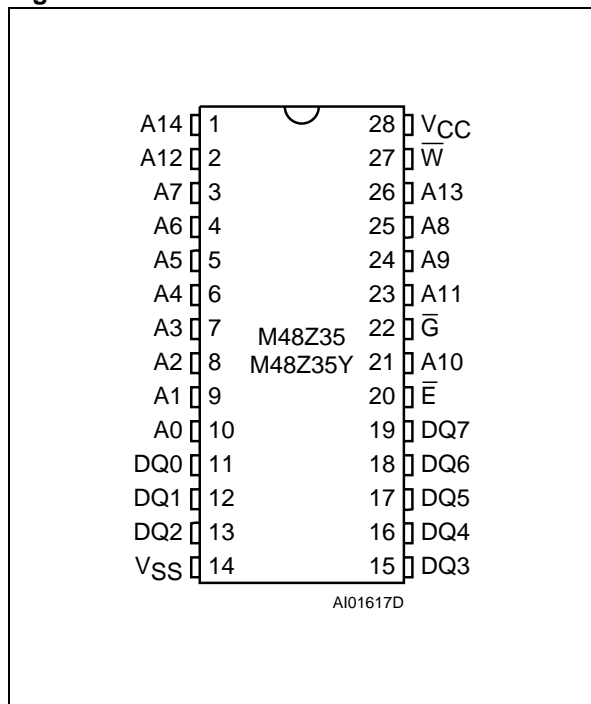
Figure 2B. SOIC Pin Connections
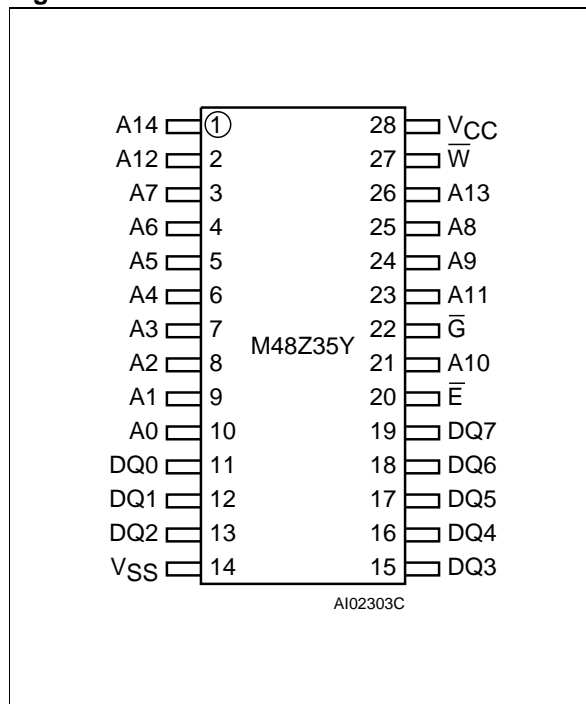
Table 2. Absolute Maximum Ratings [1]

Symbol	Parameter		Value	Unit
T_A	Ambient Operating Temperature	Grade 1 Grade 6	0 to 70 −40 to 85	°C
T_{STG}	Storage Temperature (V_{CC} Off)	SNAPHAT SOIC	−40 to 85 −55 to 125	°C
T_{SLD} [2]	Lead Solder Temperature for 10 seconds		260	°C
V_{IO}	Input or Output Voltages		−0.3 to 7	V
V_{CC}	Supply Voltage		−0.3 to 7	V
I_O	Output Current		20	mA
P_D	Power Dissipation		1	W

Note: 1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to the absolute maximum rating conditions for extended periods of time may affect reliability.

2. Soldering temperature not to exceed 260°C for 10 seconds (total thermal budget not to exceed 150°C for longer than 30 seconds).

CAUTION: Negative undershoots below −0.3V are not allowed on any pin while in the Battery Back-up mode.
*CAUTION: Do NOT wave solder SOIC to avoid damaging SNAPHAT sockets.*

Table 3. Operating Modes [1]

Mode	V_{CC}	$\overline{E}$	$\overline{G}$	$\overline{W}$	DQ0-DQ7	Power
Deselect		V_{IH}	X	X	High Z	Standby
Write	4.75V to 5.5V or 4.5V to 5.5V	V_{IL}	X	V_{IL}	D_{IN}	Active
Read		V_{IL}	V_{IL}	V_{IH}	D_{OUT}	Active
Read		V_{IL}	V_{IH}	V_{IH}	High Z	Active
Deselect	V_{SO} to V_{PFD} (min) [2]	X	X	X	High Z	CMOS Standby
Deselect	$\leq V_{SO}$	X	X	X	High Z	Battery Back-up Mode

Note: 1. X = V_{IH} or V_{IL}; V_{SO} = Battery Back-up Switchover Voltage.
2. See Table 7 for details.

Figure 3. Block Diagram
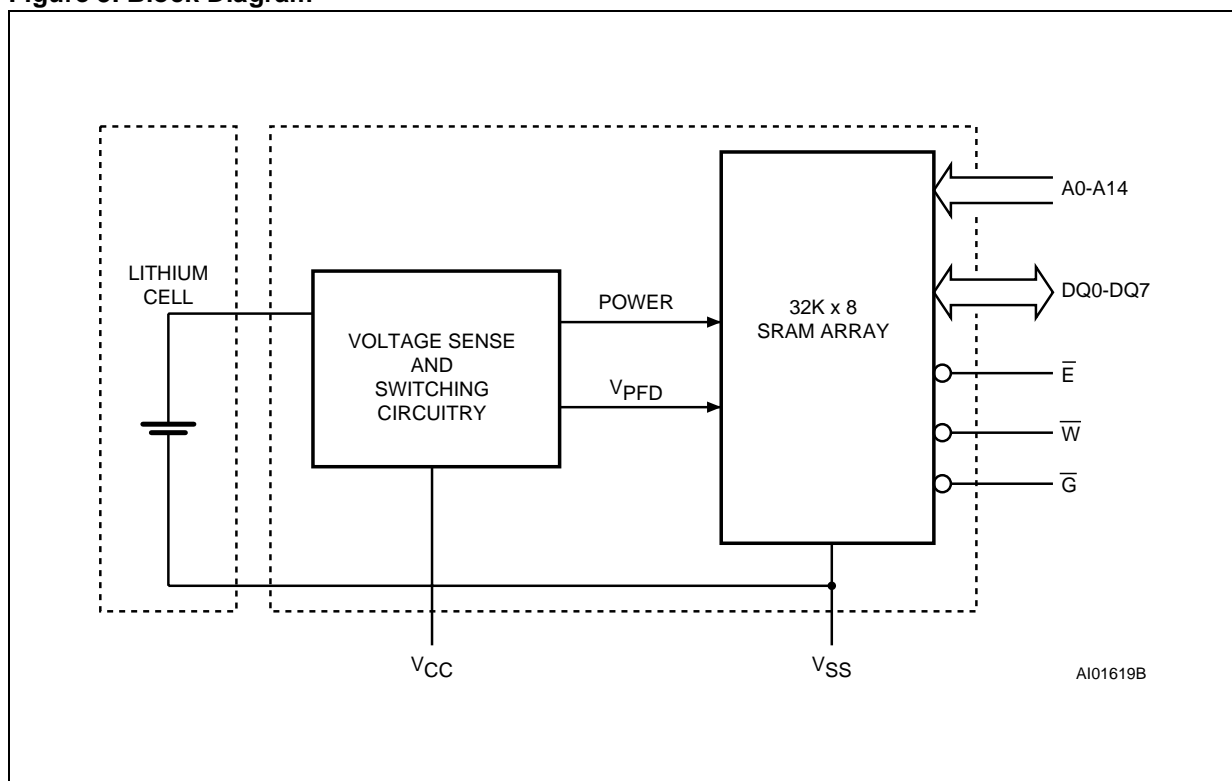
The M48Z35/35Y is a non-volatile pin and function equivalent to any JEDEC standard 32K x8 SRAM. It also easily fits into many ROM, EPROM, and EEPROM sockets, providing the non-volatility of PROMs without any requirement for special write timing or limitations on the number of writes that can be performed. The 28 pin 600mil DIP CAPHAT™ houses the M48Z35/35Y silicon with a long life lithium button cell in a single package.

The 28 pin 330mil SOIC provides sockets with gold plated contacts at both ends for direct con- nection to a separate SNAPHAT housing contain- ing the battery. The unique design allows the SNAPHAT battery package to be mounted on top of the SOIC package after the completion of the surface mount process. Insertion of the SNAPHAT housing after reflow prevents potential battery damage due to the high temperatures required for device surface-mounting. The SNAPHAT housing is keyed to prevent reverse insertion.

Table 4. AC Measurement Conditions

Input Rise and Fall Times	$\leq$ 5ns
Input Pulse Voltages	0 to 3V
Input and Output Timing Ref. Voltages	1.5V

Note that Output Hi-Z is defined as the point where data is no longer driven.

The SOIC and battery packages are shipped separately in plastic anti-static tubes or in Tape & Reel form.

For the 28 lead SOIC, the battery package (i.e. SNAPHAT) part number is "M4Z28-BR00SH1".

The M48Z35/35Y also has its own Power-fail Detect circuit. The control circuitry constantly monitors the single 5V supply for an out of tolerance condition. When V_{CC} is out of tolerance, the circuit write protects the SRAM, providing a high degree of data security in the midst of unpredictable system operation brought on by low V_{CC}. As V_{CC} falls below approximately 3V, the control circuitry connects the battery which maintains data until valid power returns.

READ MODE

The M48Z35/35Y is in the Read Mode whenever $\overline{W}$ (Write Enable) is high, $\overline{E}$ (Chip Enable) is low. The device architecture allows ripple-through access of data from eight of 264,144 locations in the static storage array. Thus, the unique address specified by the 15 Address Inputs defines which one of the 32,768 bytes of data is to be accessed. Valid data will be available at the Data I/O pins within Address Access time (t_{AVQV}) after the last address input signal is stable, providing that the $\overline{E}$ and $\overline{G}$ access times are also satisfied. If the $\overline{E}$ and $\overline{G}$ access times are not met, valid data will be available after the latter of the Chip Enable Access time (t_{ELQV}) or Output Enable Access time (t_{GLQV}).

The state of the eight three-state Data I/O signals is controlled by $\overline{E}$ and $\overline{G}$. If the outputs are activat-

Figure 4. AC Testing Load Circuit

C_L includes JIG capacitance

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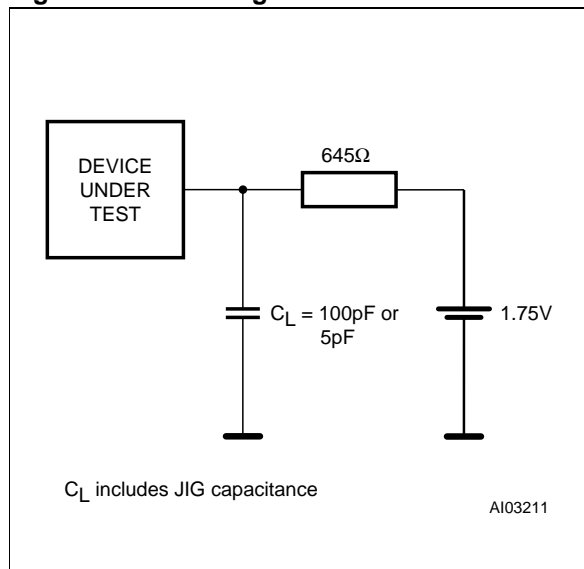
ed before t_{AVQV}, the data lines will be driven to an indeterminate state until t_{AVQV}. If the Address Inputs are changed while $\overline{E}$ and $\overline{G}$ remain active, output data will remain valid for Output Data Hold time (t_{AXQX}) but will go indeterminate until the next Address Access.

WRITE MODE

The M48Z35/35Y is in the Write Mode whenever $\overline{W}$ and $\overline{E}$ are low. The start of a write is referenced from the latter occurring falling edge of $\overline{W}$ or $\overline{E}$. A write is terminated by the earlier rising edge of $\overline{W}$ or $\overline{E}$. The addresses must be held valid throughout the cycle. $\overline{E}$ or $\overline{W}$ must return high for a minimum of t_{EHAX} from Chip Enable or t_{WHAX} from Write Enable prior to the initiation of another read or write cycle. Data-in must be valid t_{DVWH} prior to the end of write and remain valid for t_{WHDX} afterward. $\overline{G}$ should be kept high during write cycles to avoid bus contention; although, if the output bus has been activated by a low on $\overline{E}$ and $\overline{G}$, a low on $\overline{W}$ will disable the outputs t_{WLQZ} after $\overline{W}$ falls.

Table 5. Capacitance [1, 2]
($T_A = 25$ °C)

Symbol	Parameter	Test Condition	Min	Max	Unit
C_{IN}	Input Capacitance	$V_{IN} = 0V$		10	pF
C_{IO} [3]	Input / Output Capacitance	$V_{OUT} = 0V$		10	pF

Note: 1. Effective capacitance measured with power supply at 5V.
  2. Sampled only, not 100% tested.
  3. Outputs deselected.

Table 6. DC Characteristics
($T_A = 0$ to 70 °C or –40 to 85 °C; V_{CC} = 4.75V to 5.5V or 4.5V to 5.5V)

Symbol	Parameter	Test Condition	Min	Max	Unit
I_{LI} [1]	Input Leakage Current	$0V \leq V_{IN} \leq V_{CC}$		±1	μA
I_{LO} [1]	Output Leakage Current	$0V \leq V_{OUT} \leq V_{CC}$		±5	μA
I_{CC}	Supply Current	Outputs open		50	mA
I_{CC1}	Supply Current (Standby) TTL	$\overline{E} = V_{IH}$		3	mA
I_{CC2}	Supply Current (Standby) CMOS	$\overline{E} = V_{CC} - 0.2V$		3	mA
V_{IL} [2]	Input Low Voltage		–0.3	0.8	V
V_{IH}	Input High Voltage		2.2	$V_{CC} + 0.3$	V
V_{OL}	Output Low Voltage	$I_{OL} = 2.1mA$		0.4	V
V_{OH}	Output High Voltage	$I_{OH} = -1mA$	2.4		V

Note: 1. Outputs deselected.
  2. Negative spikes of –1V allowed for up to 10ns once per cycle.

Table 7. Power Down/Up Trip Points DC Characteristics [1]
($T_A = 0$ to 70 °C or –40 to 85 °C)

Symbol	Parameter	Min	Typ	Max	Unit
V_{PFD}	Power-fail Deselect Voltage (M48Z35)	4.5	4.6	4.75	V
V_{PFD}	Power-fail Deselect Voltage (M48Z35Y)	4.2	4.35	4.5	V
V_{SO}	Battery Back-up Switchover Voltage (M48Z35/35Y)		3.0		V
t_{DR} [2]	Expected Data Retention Time	10			YEARS

Note: 1. All voltages referenced to V_{SS}.
  2. At 25 °C.

Table 8. Power Down/Up AC Characteristics

(T_A = 0 to 70 °C or –40 to 85 °C)

Symbol	Parameter	Min	Max	Unit
t_{PD}	$\overline{E}$ or $\overline{W}$ at V_{IH} before Power Down	0		µs
t_F [1]	V_{PFD} (max) to V_{PFD} (min) V_{CC} Fall Time	300		µs
t_{FB} [2]	V_{PFD} (min) to V_{SS} V_{CC} Fall Time	10		µs
t_R	V_{PFD} (min) to V_{PFD} (max) V_{CC} Rise Time	10		µs
t_{RB}	V_{SS} to V_{PFD} (min) V_{CC} Rise Time	1		µs
t_{REC} [3]	V_{PFD} (max) to Inputs Recognized	40	200	ms

Note: 1. V_{PFD} (max) to V_{PFD} (min) fall time of less than t_F may result in deselection/write protection not occurring until 200µs after V_{CC} passes V_{PFD} (min).
2. V_{PFD} (min) to V_{SS} fall time of less than t_{FB} may cause corruption of RAM data.
3. t_{REC} (min) = 20ms for industrial temperature grade (6) device.
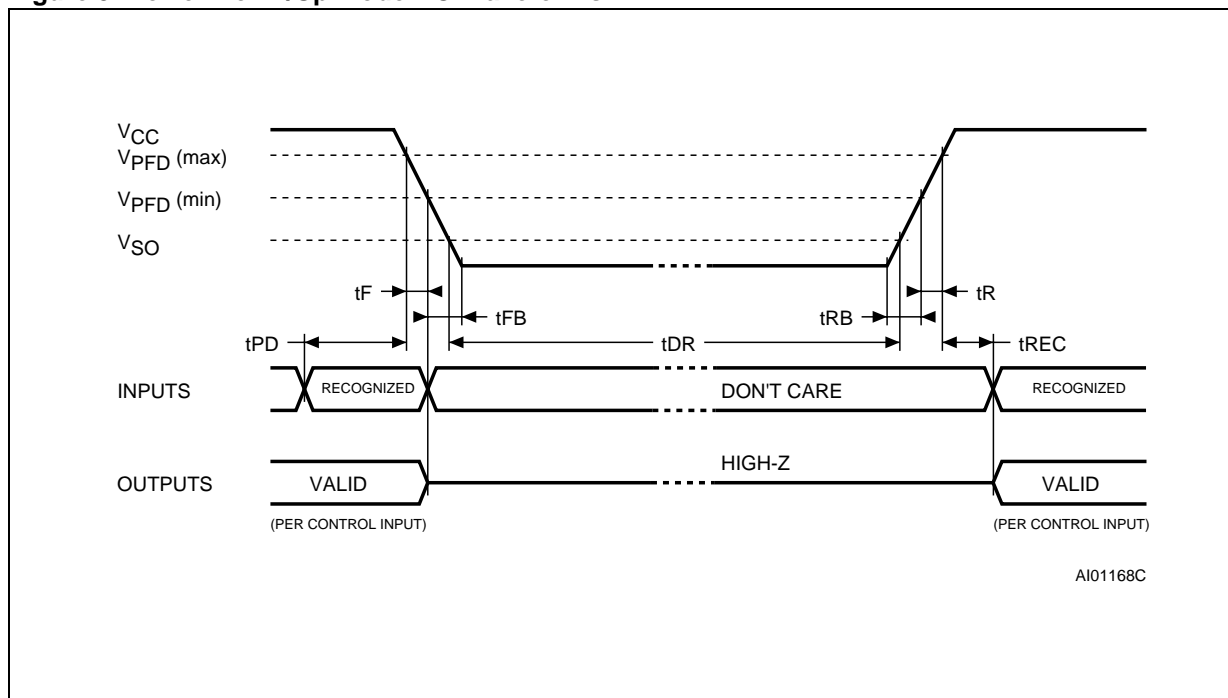
Figure 5. Power Down/Up Mode AC Waveforms

Table 9. Read Mode AC Characteristics

(T_A = 0 to 70 °C or –40 to 85 °C; V_{CC} = 4.75V to 5.5V or 4.5V to 5.5V)

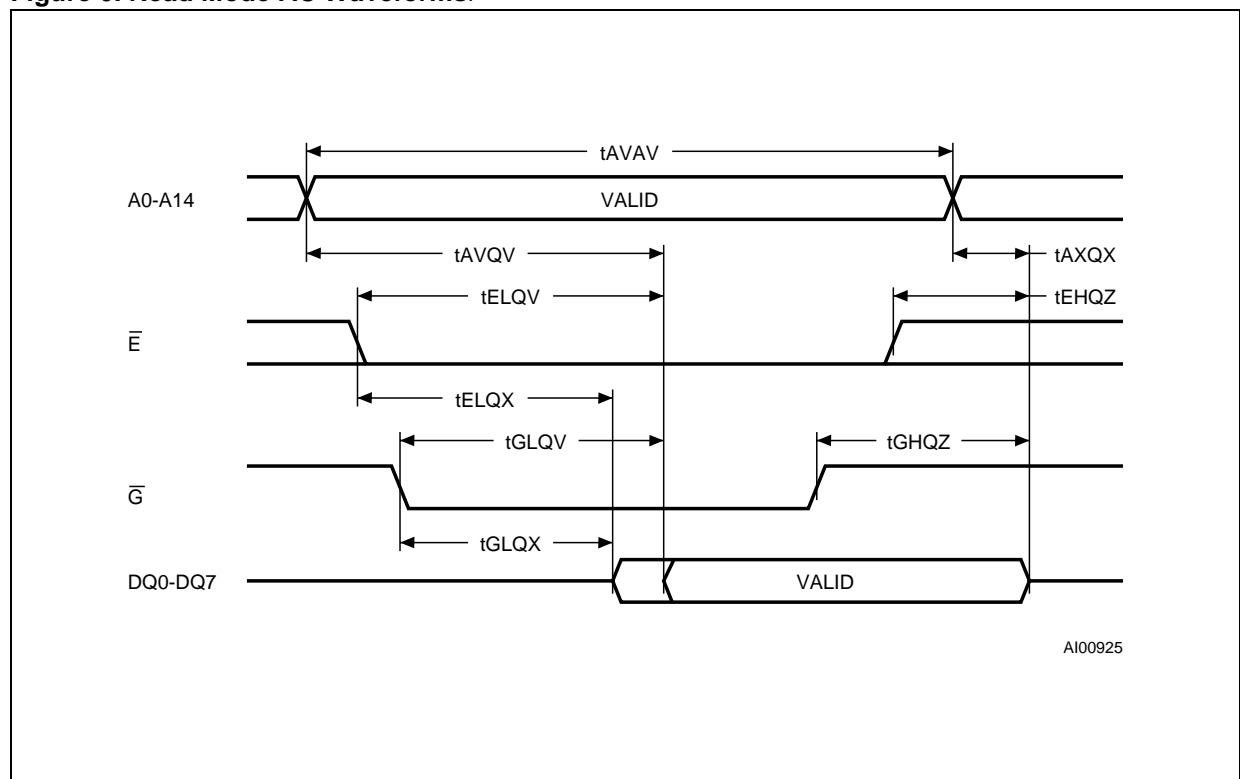| Symbol	Parameter	M48Z35 / M48Z35Y		Unit
		-70		
		Min	Max	
t_{AVAV}	Read Cycle Time	70		ns
t_{AVQV} [1]	Address Valid to Output Valid		70	ns
t_{ELQV} [1]	Chip Enable Low to Output Valid		70	ns
t_{GLQV} [1]	Output Enable Low to Output Valid		35	ns
t_{ELQX} [2]	Chip Enable Low to Output Transition	5		ns
t_{GLQX} [2]	Output Enable Low to Output Transition	5		ns
t_{EHQZ} [2]	Chip Enable High to Output Hi-Z		25	ns
t_{GHQZ} [2]	Output Enable High to Output Hi-Z		25	ns
t_{AXQX} [1]	Address Transition to Output Transition	10		ns

Note: 1. C_L = 100pF (see Figure 4).
2. C_L = 5pF (see Figure 4).

Figure 6. Read Mode AC Waveforms.

Note: Write Enable ($\overline{W}$) = High.

Table 10. Write Mode AC Characteristics
(T_A = 0 to 70 °C or –40 to 85 °C; V_{CC} = 4.75V to 5.5V or 4.5V to 5.5V)

Symbol	Parameter	M48Z35 / M48Z35Y -70 Min	M48Z35 / M48Z35Y -70 Max	Unit
t_{AVAV}	Write Cycle Time	70		ns
t_{AVWL}	Address Valid to Write Enable Low	0		ns
t_{AVEL}	Address Valid to Chip Enable Low	0		ns
t_{WLWH}	Write Enable Pulse Width	50		ns
t_{ELEH}	Chip Enable Low to Chip Enable High	55		ns
t_{WHAX}	Write Enable High to Address Transition	0		ns
t_{EHAX}	Chip Enable High to Address Transition	0		ns
t_{DVWH}	Input Valid to Write Enable High	30		ns
t_{DVEH}	Input Valid to Chip Enable High	30		ns
t_{WHDX}	Write Enable High to Input Transition	5		ns
t_{EHDX}	Chip Enable High to Input Transition	5		ns
t_{WLQZ} [1, 2]	Write Enable Low to Output Hi-Z		25	ns
t_{AVWH}	Address Valid to Write Enable High	60		ns
t_{AVEH}	Address Valid to Chip Enable High	60		ns
t_{WHQX} [1, 2]	Write Enable High to Output Transition	5		ns

Note: 1. C_L = 5pF (see Figure 4).
2. If $\overline{E}$ goes low simultaneously with $\overline{W}$ going low, the outputs remain in the high impedance state.

DATA RETENTION MODE

With valid V_{CC} applied, the M48Z35/35Y operates as a conventional BYTEWIDE™ static RAM. Should the supply voltage decay, the RAM will automatically power-fail deselect, write protecting itself when V_{CC} falls within the V_{PFD}(max), V_{PFD}(min) window. All outputs become high impedance, and all inputs are treated as "don't care."

Note: A power failure during a write cycle may corrupt data at the currently addressed location, but does not jeopardize the rest of the RAM's content. At voltages below V_{PFD}(min), the user can be assured the memory will be in a write protected state, provided the V_{CC} fall time is not less than t_F. The M48Z35/35Y may respond to transient noise spikes on V_{CC} that reach into the deselect window during the time the device is sampling V_{CC}. There-

fore, decoupling of the power supply lines is recommended.

When V_{CC} drops below V_{SO}, the control circuit switches power to the internal battery which preserves data. The internal button cell will maintain data in the M48Z35/35Y for an accumulated period of at least 10 years (at 25°C) when V_{CC} is less than V_{SO}.

As system power returns and V_{CC} rises above V_{SO}, the battery is disconnected, and the power supply is switched to external V_{CC}. Write protection continues until V_{CC} reaches V_{PFD}(min) plus t_{REC}(min). Normal RAM operation can resume t_{REC} after V_{CC} exceeds V_{PFD}(max).

For more information on Battery Storage Life refer to the Application Note AN1012.

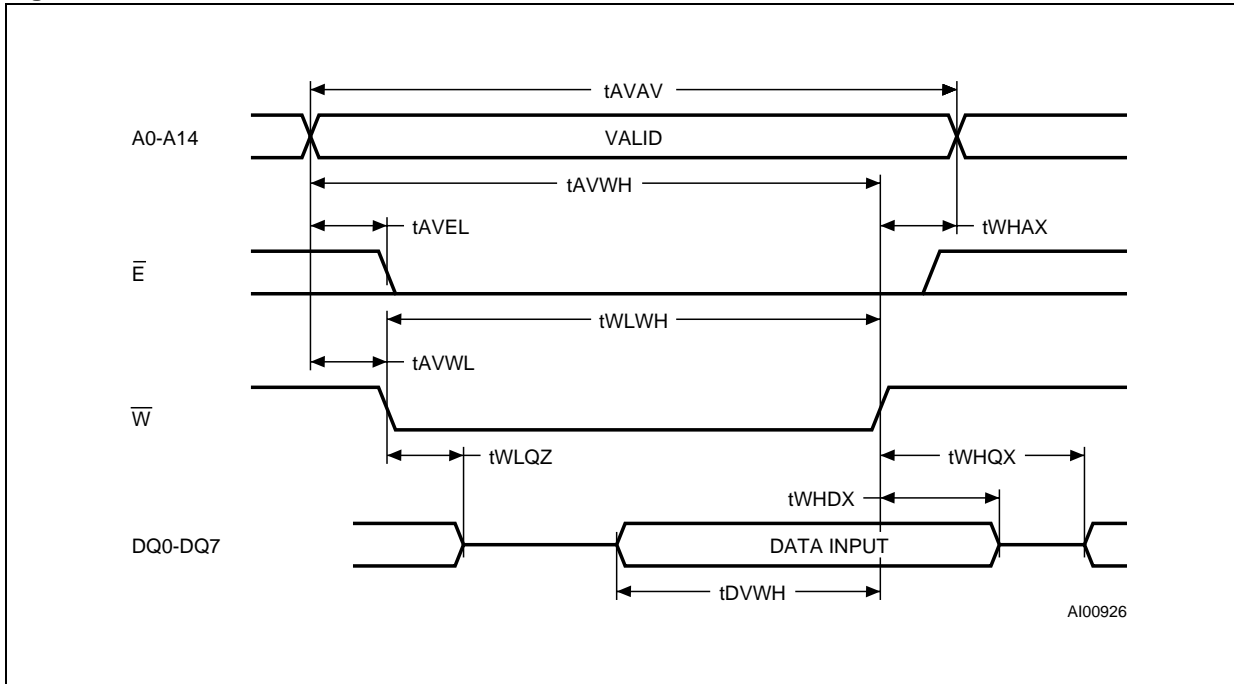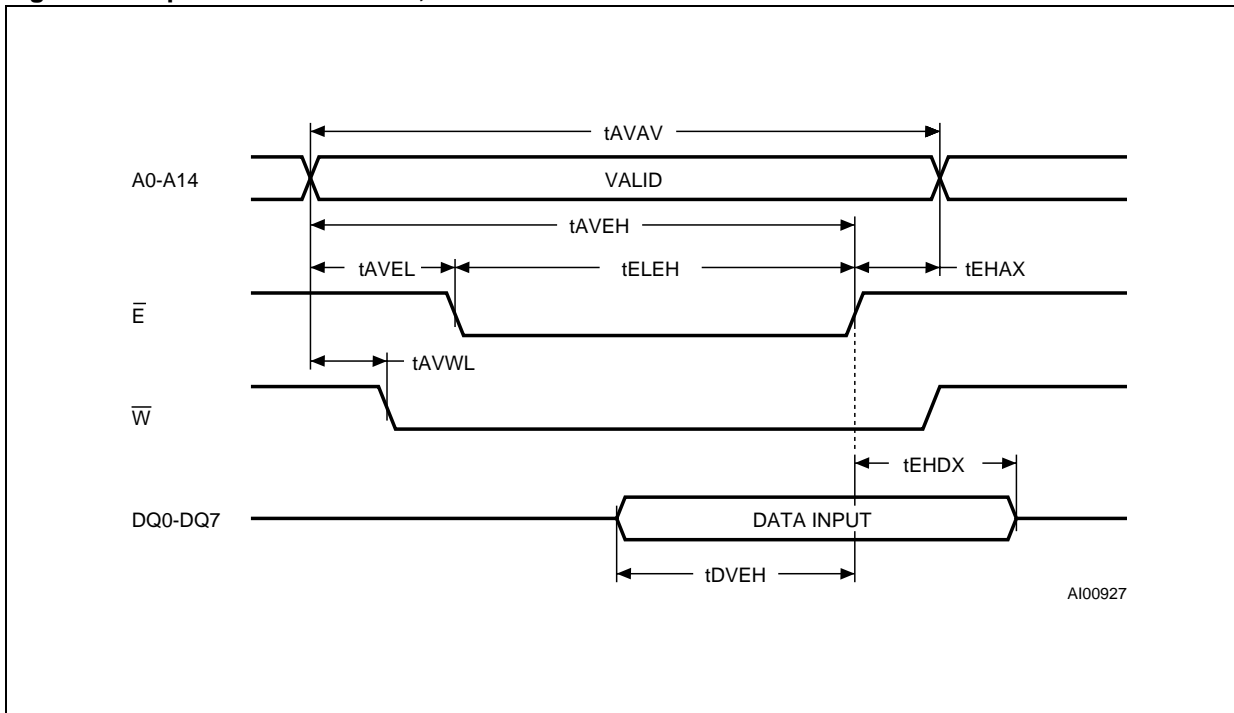**Figure 7. Write Enable Controlled, Write AC Waveform**

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Figure 8. Chip Enable Controlled, Write AC Waveforms

AI00927

POWER SUPPLY DECOUPLING and UNDERSHOOT PROTECTION

I_{CC} transients, including those produced by output switching, can produce voltage fluctuations, resulting in spikes on the V_{CC} bus. These transients can be reduced if capacitors are used to store energy, which stabilizes the V_{CC} bus. The energy stored in the bypass capacitors will be released as low going spikes are generated or energy will be absorbed when overshoots occur. A ceramic bypass capacitor value of 0.1µF (as shown in Figure 9) is recommended in order to provide the needed filtering.

In addition to transients that are caused by normal SRAM operation, power cycling can generate negative voltage spikes on V_{CC} that drive it to values below V_{SS} by as much as one Volt. These negative spikes can cause data corruption in the SRAM while in battery backup mode. To protect from these voltage spikes, it is recommended to connect a schottky diode from V_{CC} to V_{SS} (cathode connected to V_{CC}, anode to V_{SS}). Schottky diode 1N5817 is recommended for through hole and MBRS120T3 is recommended for surface mount.
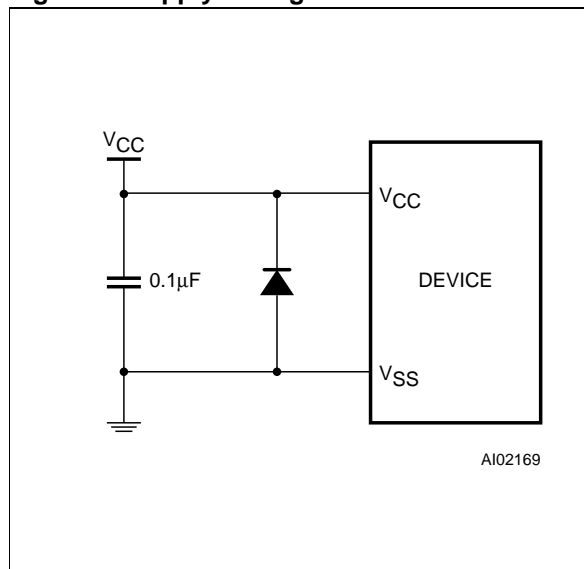
Figure 9. Supply Voltage Protection

Table 11. Ordering Information Scheme

Example: M48Z35Y   -70 MH 1 TR

Supply Voltage and Write Protect Voltage
35 $^{(1)}$ = V_{CC} = 4.75V to 5.5V; V_{PFD} = 4.5V to 5.5V
35Y = V_{CC} = 4.5V to 5.5V; V_{PFD} = 4.2V to 4.5V

Speed
-70 = 70ns

Package
PC = PCDIP28
MH $^{(2, 3)}$ = SOH28

Temperature Range
1 = 0 to 70 °C
6 $^{(4)}$ = –40 to 85 °C

Shipping Method for SOIC
blank = Tubes
TR = Tape & Reel

Note: 1. The M48Z35 part is offered with the PCDIP28 (CAPHAT) package only.
2. The SOIC package (SOH28) requires the battery package (SNAPHAT) which is ordered separately under the part number "M4Zxx-BR00SH1" in plastic tube or "M4Zxx-BR00SH1TR" in Tape & Reel form.
3. Delivery may include either the 2-pin version of the SOIC/SNAPHAT or the 4-pin version of the SOIC/SNAPHAT. Both are function-ally equivalent (see package drawing section for details).
4. Industrial temperature grade available in SOIC package (SOH28) only.

Caution: Do not place the SNAPHAT battery package "M4Z28-BR00SH1" in conductive foam since will drain the lithium button-cell battery.

For a list of available options (Speed, Package, etc...) or for further information on any aspect of this device, please contact the STMicroelectronics Sales Office nearest to you.

Table 12. PCDIP28 - 28 pin Plastic DIP, battery CAPHAT, Package Mechanical Data

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A		8.89	9.65		0.350	0.380
A1		0.38	0.76		0.015	0.030
A2		8.38	8.89		0.330	0.350
B		0.38	0.53		0.015	0.021
B1		1.14	1.78		0.045	0.070
C		0.20	0.31		0.008	0.012
D		39.37	39.88		1.550	1.570
E		17.83	18.34		0.702	0.722
e1		2.29	2.79		0.090	0.110
e3		29.72	36.32		1.170	1.430
eA		15.24	16.00		0.600	0.630
L		3.05	3.81		0.120	0.150
N	28			28		

**Figure 10. PCDIP28 - 28 pin Plastic DIP, battery CAPHAT, Package Outline**
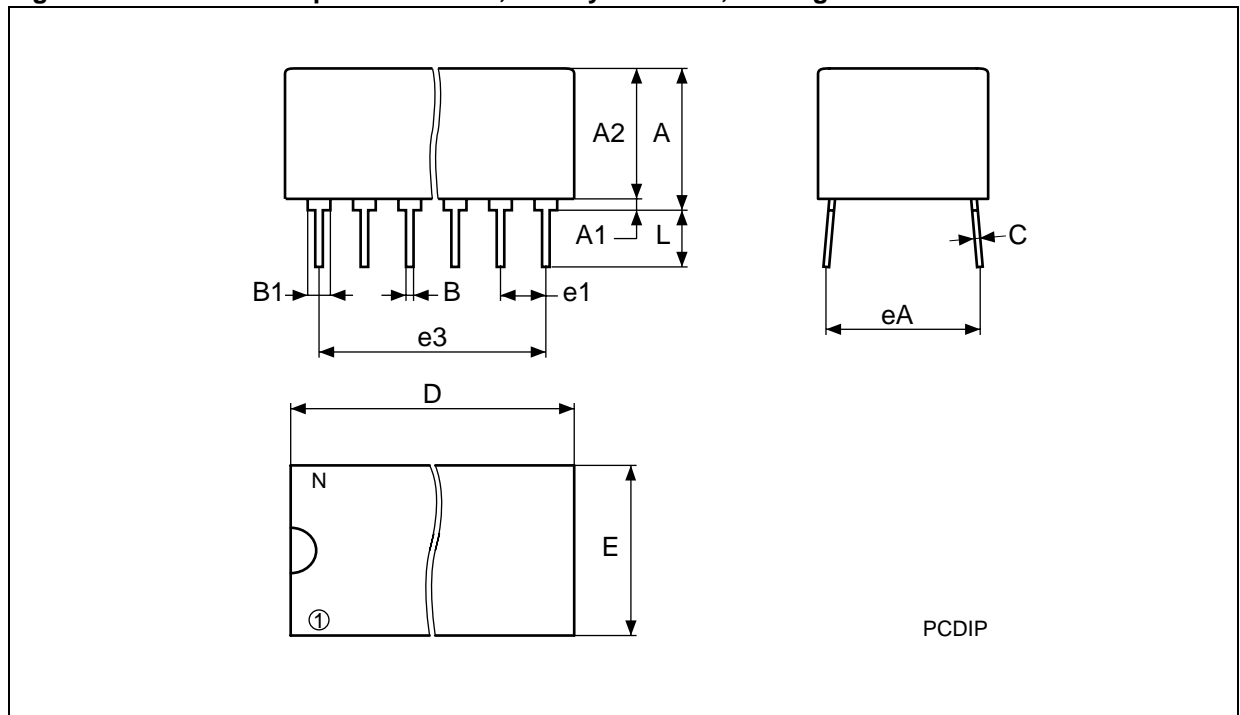
Drawing is not to scale.

Table 13. SOH28 - 28 lead Plastic Small Outline, 4-socket battery SNAPHAT,
Package Mechanical Data

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			3.05			0.120
A1		0.05	0.36		0.002	0.014
A2		2.34	2.69		0.092	0.106
B		0.36	0.51		0.014	0.020
C		0.15	0.32		0.006	0.012
D		17.71	18.49		0.697	0.728
E		8.23	8.89		0.324	0.350
e	1.27	–	–	0.050	–	–
eB		3.20	3.61		0.126	0.142
H		11.51	12.70		0.453	0.500
L		0.41	1.27		0.016	0.050
α		0°	8°		0°	8°
N		28			28	
CP			0.10			0.004

Figure 11. SOH28 - 28 lead Plastic Small Outline, 4-socket battery SNAPHAT, Package Outline

SOH-A
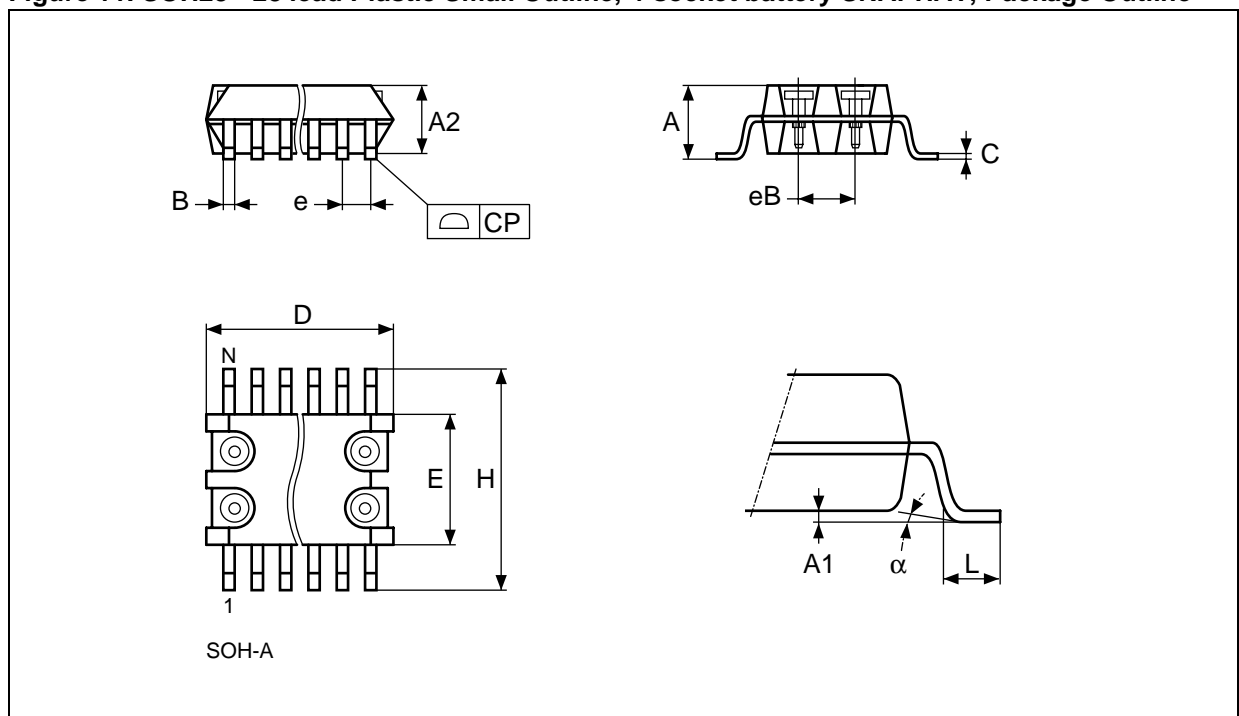
Drawing is not to scale.

**Table 14. SOH28 - 28 lead Plastic Small Outline, 2-socket battery SNAPHAT,
Package Mechanical Data**

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			3.05			0.120
A1		0.05	0.36		0.002	0.014
A2		2.34	2.69		0.092	0.106
B		0.36	0.51		0.014	0.020
C		0.15	0.32		0.006	0.012
D		17.71	18.49		0.697	0.728
E		8.23	8.89		0.324	0.350
e	1.27	–	–	0.050	–	–
eB		3.20	3.61		0.126	0.142
H		11.51	12.70		0.453	0.500
L		0.41	1.27		0.016	0.050
α		0°	8°		0°	8°
N		28			28	
CP			0.10			0.004

Figure 12. SOH28 - 28 lead Plastic Small Outline, 2-socket battery SNAPHAT, Package Outline

SOH-B
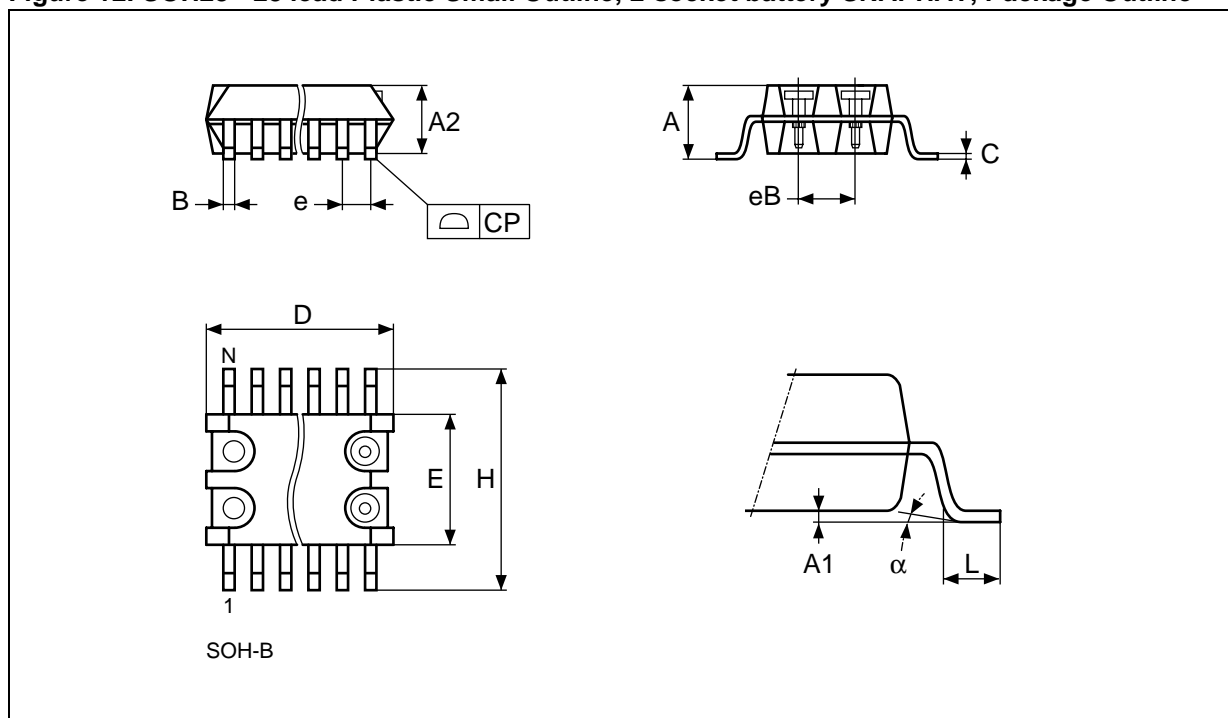
Drawing is not to scale.

Table 15. SH - 4-pin SNAPHAT Housing for 49 mAh Battery, Package Mechanical Data

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			9.78			0.385
A1		6.73	7.24		0.265	0.285
A2		6.48	6.99		0.255	0.275
A3			0.38			0.015
B		0.46	0.56		0.018	0.022
D		21.21	21.84		0.835	0.860
E		14.22	14.99		0.560	0.590
eA		15.55	15.95		0.612	0.628
eB		3.20	3.61		0.126	0.142
L		2.03	2.29		0.080	0.090

Figure 13. SH - 4-pin SNAPHAT Housing for 49 mAh Battery, Package Outline

SHZP-A
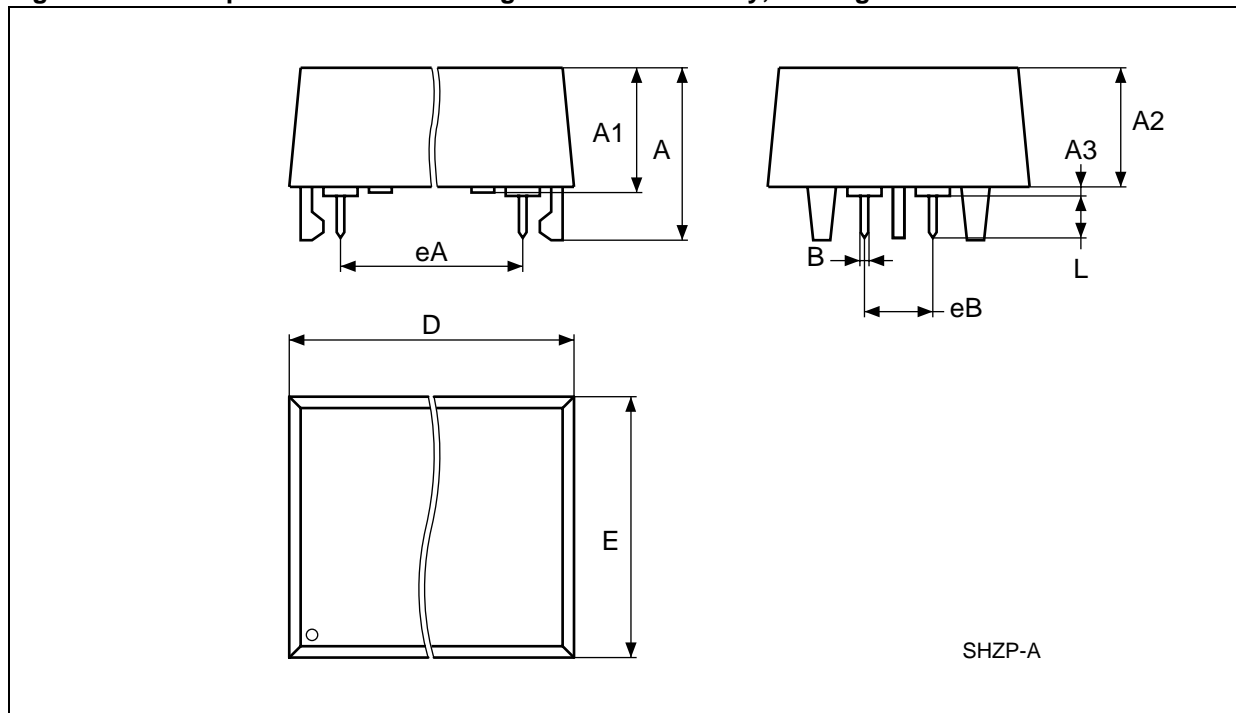
Drawing is not to scale.

Table 16. SH - 2-pin SNAPHAT Housing for 49 mAh Battery, Package Mechanical Data

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			9.78			0.385
A1		6.73	7.24		0.265	0.285
A2		6.48	6.99		0.255	0.275
A3			0.38			0.015
B		0.46	0.56		0.018	0.022
D		21.21	21.84		0.835	0.860
E		14.22	14.99		0.560	0.590
eB		3.20	3.61		0.126	0.142
L		2.03	2.29		0.080	0.090

Figure 14. SH - 2-pin SNAPHAT Housing for 49 mAh Battery, Package Outline

SHZP-B
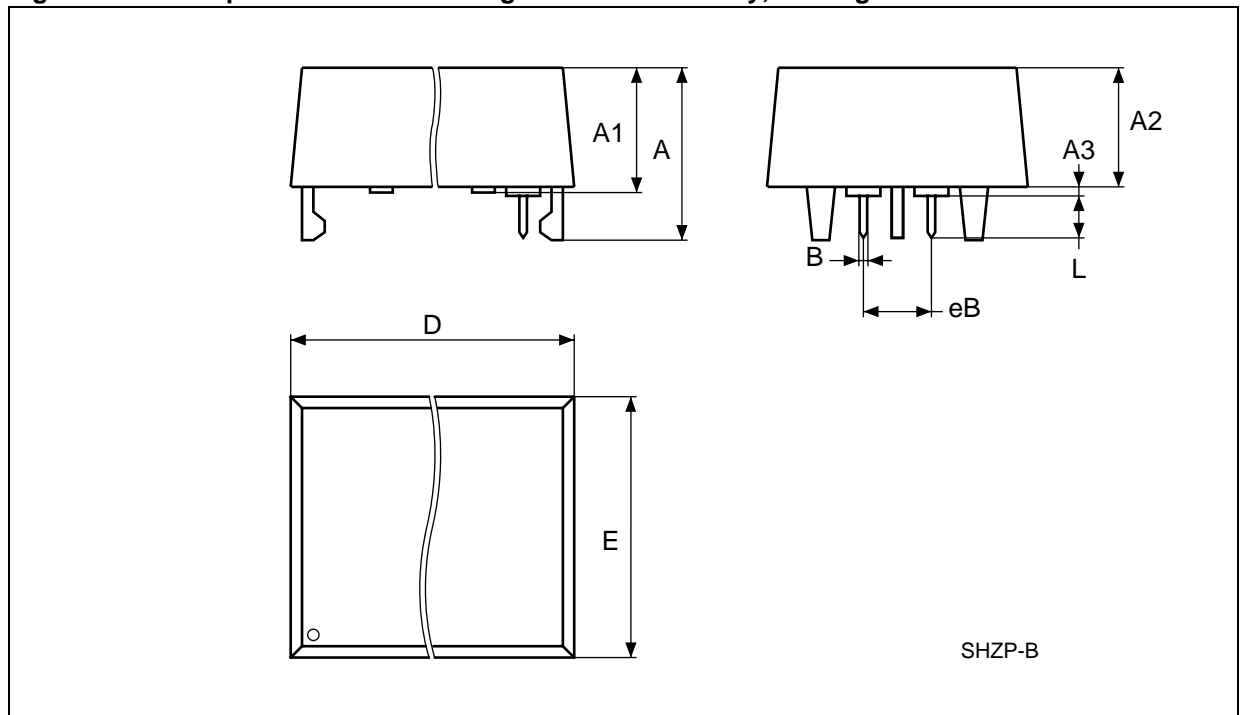
Drawing is not to scale.

Table 17. SH - 2-pin SNAPHAT Housing for 130 mAh Battery, Package Mechanical Data

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			10.54			0.415
A1		8.00	8.51		0.315	0.335
A2		7.24	8.00		0.285	0.315
A3			0.38			0.015
B		0.46	0.56		0.018	0.022
D		21.21	21.84		0.835	0.860
E		17.27	18.03		0.680	0.710
eB		3.20	3.61		0.126	0.142
L		2.03	2.29		0.080	0.090

Figure 15. SH - 2-pin SNAPHAT Housing for 130 mAh Battery, Package Outline

SHZP-B

Drawing is not to scale.